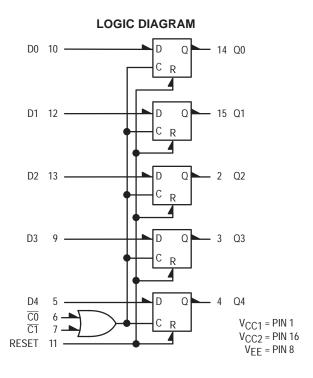
Quint Latch

The MC10175 is a high speed, low power quint latch. It features five D type latches with common reset and a common two-input clock. Data is transferred on the negative edge of the clock and latched on the positive edge. The two clock inputs are "OR"ed together.

Any change on the data input will be reflected at the outputs while the clock is low. The outputs are latched on the positive transition of the clock. While the clock is in the high state, a change in the information present at the data inputs will not affect the output information. The reset input is enabled only when the clock is in the high state.

- $P_D = 400 \text{ mW typ/pkg (No Load)}$
- $t_{pd} = 2.5$ ns typ (Data to Output)
- t_r , $t_f = 2.0$ ns typ (20%–80%)



TRUTH TABLE

D	C0	C1	Reset	Q _{n+1}
L	L	L	Х	L
Н	L	L	Х	Н
X	Н	Х	L	Qn
X	Χ	Н	L	Qn
X	Н	Х	Н	L
Х	Χ	Н	Н	L



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CDIP-16 L SUFFIX CASE 620 MC10175L AWLYYWW

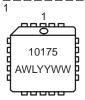


PDIP-16 P SUFFIX CASE 648





PLCC-20 FN SUFFIX CASE 775



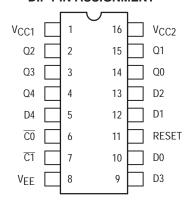
A = Assembly Location

WL = Wafer Lot

YY = Year

WW = Work Week

DIP PIN ASSIGNMENT



Pin assignment is for Dual–in–Line Package.
For PLCC pin assignment, see the Pin Conversion Tables on page 18 of the ON Semiconductor MECL Data Book (DL122/D).

ORDERING INFORMATION

Device	Package	Shipping
MC10175L	CDIP-16	25 Units / Rail
MC10175P	PDIP-16	25 Units / Rail
MC10175FN	PLCC-20	46 Units / Rail

ELECTRICAL CHARACTERISTICS

			Test Limits							
		Pin Under	−30°C		+25°C		+85°C		1	
Characteristic	Symbol	Test	Min	Max	Min	Тур	Max	Min	Max	Unit
Power Supply Drain Current	ΙE	8		107		78	97		107	mAdc
Input Current	l _{inH}	6 7 10 11		460 460 460 1000			290 290 290 650		290 290 290 650	μAdc
	linL	All	0.5		0.5			0.3		μAdc
Output Voltage Logic 1	VOH	14 15	-1.060 -1.060	-0.890 -0.890	-0.960 -0.960		-0.810 -0.810	-0.890 -0.890	-0.700 -0.700	Vdc
Output Voltage Logic 0	VOL	14 15	-1.890 -1.890	-1.675 -1.675	-1.850 -1.850		-1.650 -1.650	-1.825 -1.825	-1.615 -1.615	Vdc
Threshold Voltage Logic 1	Vона	14 15	-1.080 -1.080		-0.980 -0.980			-0.910 -0.910		Vdc
Threshold Voltage Logic 0	VOLA	14 15		-1.655 -1.655			-1.630 -1.630		-1.595 -1.595	Vdc
Switching Times (50 Ω Load)										ns
Data Input	t ₁₀₊₁₄₊ t ₁₀₋₁₄₋	14 14	1.0 1.0	3.6 3.6	1.0 1.0		3.5 3.5	1.0 1.0	3.6 3.6	
Clock Input	t ₆₋₁₄₊	14 14	1.0 1.0	4.7 4.7	1.0 1.0		4.3 4.3	1.0 1.0	4.4 4.4	
Reset Input	t ₁₁₊₄	4 14	1.0 1.0	4.0 4.0	1.0 1.0		3.9 3.9	1.0 1.0	4.2 4.2	
Setup TIme Hold Time	t _{setup}	14 14	2.5 1.5		2.5 1.5			2.5 1.5		
Rise Time (20 to 80%)	t+	14	1.0	3.6	1.1		3.5	1.1	3.7	
Fall Time (20 to 80%)	t–	14	1.0	3.6	1.1		3.5	1.1	3.7	

Individually test each input; apply V_{ILmin} to pin under test.
 Output latched to high logic state prior to test.

ELECTRICAL CHARACTERISTICS (continued)

					TEST VOI	LTAGE VALU	JES (Volts)		
		@ Test Te	mperature	V _{IHmax}	V _{ILmin}	VIHAmin	V _{ILAmax}	VEE	1
			–30°C	-0.890	-1.890	-1.205	-1.500	-5.2	1
			+25°C	-0.810	-1.850	-1.105	-1.475	-5.2	1
			+85°C	-0.700	-1.825	-1.035	-1.440	-5.2	1
			Pin	TEST VOLTAGE APPLIED TO PINS LISTED BELOW]
Character	istic	Symbol	Under Test	V _{IHmax}	V _{ILmin}	VIHAmin	V _{ILAmax}	VEE	(VCC)
Power Supply Drain (Current	ΙΕ	8					8	1, 16
Input Current		linH	6 7 10 11	6 7 10 11				8 8 8	1, 16 1, 16 1, 16 1, 16
		l _{inL}	All		Note 1.			8	1, 16
Output Voltage	Logic 1	Voн	14 15	10 12	6 6			8 8	1, 16 1, 16
Output Voltage	Logic 0	V _{OL}	14 15		6, 10 6, 12			8 8	1, 16 1, 16
Threshold Voltage	Logic 1	Vона	14 15		6 6	10 12		8 8	1, 16 1, 16
Threshold Voltage	Logic 0	VOLA	14 15		6 6		10 12	8 8	1, 16 1, 16
Switching Times	(50Ω Load)			+1.11V	+0.31V	Pulse In	Pulse Out	−3.2 V	+2.0 V
	Data Input	^t 10+14+ ^t 10–14–	14 14		6, 7 6, 7	10 10	14 14	8 8	1, 16 1, 16
	Clock Input	^t 6–14+ ^t 6–14–	14 14		7 7	10, 6 10, 6	14 14	8 8	1, 16 1, 16
	Reset Input	^t 11+4– ^t 11+14–	4 14	5 10	6 6	7, 11 7, 11	4 (2.) 14 (2.)	8 8	1, 16 1, 16
Setup TIme Hold Time		^t setup ^t hold	14 14		7 7	6, 10 6, 10	14 14	8 8	1, 16 1, 16
Rise Time	(20 to 80%)	t+	14		6, 7	10	14	8	1, 16
Fall Time	(20 to 80%)	t–	14		6, 7	10	14	8	1, 16

^{1.} Individually test each input; apply V_{ILmin} to pin under test.

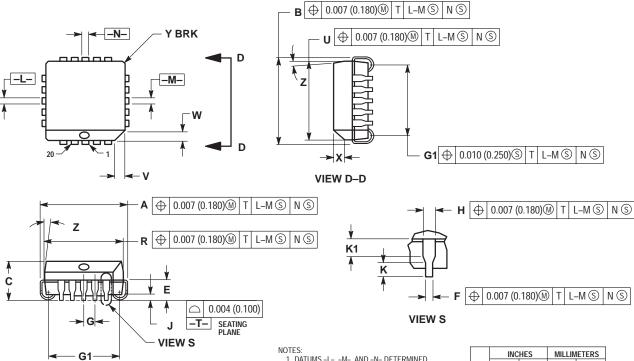
Each MECL 10,000 series circuit has been designed to meet the dc specifications shown in the test table, after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear fpm is maintained. Outputs are terminated through a 50–ohm resistor to –2.0 volts. Test procedures are shown for only one gate. The other gates are tested in the same manner.

^{2.} Output latched to high logic state prior to test.

PACKAGE DIMENSIONS

PLCC-20 **FN SUFFIX**

PLASTIC PLCC PACKAGE CASE 775-02 ISSUE C



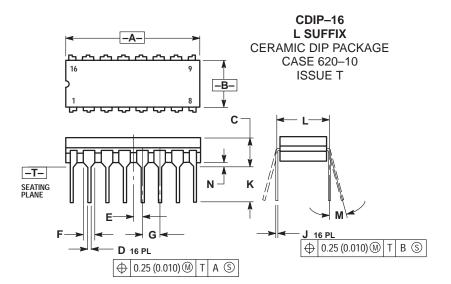
⊕ 0.010 (0.250)⑤ T L-M ⑤ N ⑤

- DATUMS -L-, -M-, AND -N- DETERMINED
 WHERE TOP OF LEAD SHOULDER EXITS PLASTIC WILLY LOVE LEAD STOUDER EXTENSIVE SOLUTION TO BE MEASURED AT DATUM -T-, SEATING PLANE.

 3. DIMENSIONS R AND U DO NOT INCLUDE MOLD
- FLASH. ALLOWABLE MOLD FLASH IS 0.010 (0.250) PER SIDE.
 4. DIMENSIONING AND TOLERANCING PER ANSI
- Y14.5M, 1982. 5. CONTROLLING DIMENSION: INCH.
- 6. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM BY UP TO 0.012 (0.300). DIMENSIONS R AND U ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR BURRS, GATE BURRS AND INTERLEAD FLASH, BUT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
- DIMENSION H DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBAR PROTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE GREATER THAN 0.037 (0.940). THE DAMBAR INTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE SMALLER THAN 0.025 (0.635).

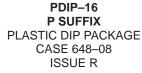
	INC	HES	MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.385	0.395	9.78	10.03
В	0.385	0.395	9.78	10.03
С	0.165	0.180	4.20	4.57
Ε	0.090	0.110	2.29	2.79
F	0.013	0.019	0.33	0.48
G	0.050	BSC	1.27	BSC
Н	0.026	0.032	0.66	0.81
J	0.020		0.51	
K	0.025		0.64	
R	0.350	0.356	8.89	9.04
U	0.350	0.356	8.89	9.04
٧	0.042	0.048	1.07	1.21
W	0.042	0.048	1.07	1.21
Х	0.042	0.056	1.07	1.42
Υ		0.020		0.50
Z	2°	10°	2°	10 °
G1	0.310	0.330	7.88	8.38
K1	0.040		1.02	

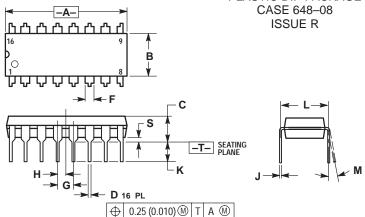
PACKAGE DIMENSIONS



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH.
 3. DIMENSION L TO CENTER OF LEAD WHEN FORMED PARALLEL.
 4. DIMENSION F MAY NARROW TO 0.76 (0.030) WHERE THE LEAD ENTERS THE CERAMIC BODY.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.750	0.785	19.05	19.93	
В	0.240	0.295	6.10	7.49	
С		0.200		5.08	
D	0.015	0.020	0.39	0.50	
Ε	0.050	BSC	1.27 BSC		
F	0.055	0.065	1.40	1.65	
G	0.100	BSC	2.54 BSC		
Н	0.008	0.015	0.21	0.38	
K	0.125	0.170	3.18	4.31	
L	0.300	BSC	7.62 BSC		
M	0°	15°	0°	15°	
N	0.020	0.040	0.51	1.01	





- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

 2. CONTROLLING DIMENSION: INCH.

 3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.

 4. DIMENSION B DOES NOT INCLUDE MOLD FLASH.

 5. ROUNDED CORNERS OPTIONAL.

	INC	HES	MILLIMETERS		
DIM	MIN	MIN MAX		MAX	
Α	0.740	0.770	18.80	19.55	
В	0.250	0.270	6.35	6.85	
С	0.145	0.175	3.69	4.44	
D	0.015	0.021	0.39	0.53	
F	0.040	0.70	1.02	1.77	
G	0.100	BSC	2.54 BSC		
Н	0.050	BSC	1.27	BSC	
J	0.008	0.015	0.21	0.38	
K	0.110	0.130	2.80	3.30	
L	0.295	0.305	7.50	7.74	
M	0°	10 °	0 °	10 °	
S	0.020	0.040	0.51	1.01	

Notes

Notes

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